Search Notes

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
09/544,289	HIYOSHI, TAKAYUK	l	
Examiner	Art Unit		

2861

Hai C. Pham

	SEARCHED				
Class	Subclass	Date	Examiner		
347	129-130, 238, 241- 242, 256- 257	1/20/2006	НР		
257	82, 88-89	1/20/2006	HP		
362	611-614	1/20/2006	HP		
	-				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	130, 238	1/20/2006	HP
PGPub To	ext search	1/20/2006	,HP

SEARC (INCLUDING SEA	H NOTES ARCH STRATEGY	)
	DATE	EXMR
EAST Text Search	1/11/2006	НР
EAST Text Search	1/20/2006	НР
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